

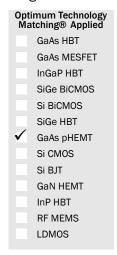
50 MHz to 4000 MHz, GaAs pHEMT LOW NOISE MMIC AMPLIFIER

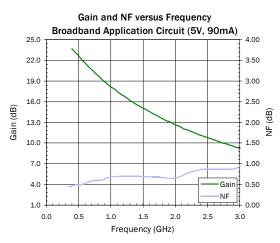




Product Description

The SPF5122Z is a high performance pHEMT MMIC LNA designed for operation from 50 MHz to 4000 MHz. The on-chip active bias network provides stable current over temperature and process threshold voltage variations. The SPF5122Z offers ultra-low noise figure and high linearity performance in a gain block configuration. Its single-supply operation and integrated matching networks make implementation remarkably simple. A high maximum input power specification make it ideal for high dynamic range receivers.





Features

- Ultra-Low Noise Figure=0.60dB at 900MHz
- Gain=18.9dB at 900MHz
- High Linearity: OIP3=40.5dBm at 1900MHz
- Channel Power=13.4dBm (-65dBc IS95 ACPR, 880MHz)
- P_{1dB}=23.4dBm at 1900MHz
- Single-Supply Operation: 5V at I_{DO}=90 mA
- Flexible Biasing Options: 3-5V, Adjustable Current
- Broadband Internal Matching

Applications

- Cellular, PCS, W-CDMA, ISM, WiMAX Receivers
- PA Driver Amplifier
- Low Noise, High Linearity Gain Block Applications

Parameter	Specification			Unit	Open ditions	
raiailletei	Min.	Тур.	Max.	UIIIL	Condition	
Small Signal Power Gain	17.2	18.9	20.2	dB	0.9GHz	
	11.2	12.2	14.4	dB	1.96GHz	
Output Power at 1dB Compression	20.8	22.8		dBm	0.9GHz	
	21.4	23.4		dBm	1.9GHz	
Output Third Order Intercept Point	35.1	38.1		dBm	0.9GHz	
	37.2	40.5		dBm	1.9GHz	
Noise Figure		0.59	0.85	dB	0.9GHz	
		0.65	0.9	dB	1.9GHz	
Input Return Loss	10	14.3		dB	0.9 GHz	
		21		dB	1.9GHz	
Output Return Loss	14	17		dB	0.9GHz	
		13		dB	1.9GHz	
Reverse Isolation		24.1		dB	0.9GHz	
		18.4		dB	1.9GHz	
Device Operating Voltage		5.00	5.25	V		
Device Operating Current	75	90	105	mA	Quiescent	
Thermal Resistance		65		°C/W	Junction to lead	

Test Conditions: $V_D = 5V$, $I_{DO} = 90$ mA, OIP_3 Tone Spacing = 1MHz, P_{OIIT} per tone = 0 dBm, $Z_S = Z_I = 50 \Omega$, $25 \, ^{\circ}$ C, Broadband Application Circuit



Absolute Maximum Ratings

Parameter	Rating	Unit
Max Device Current (I _D)	120	mA
Max Device Voltage (V _D)	5.5	V
Max RF Input Power	27	dBm
Max Dissipated Power	660	mW
Max Junction Temperature (T _J)	150	°C
Operating Temperature Range (T _L)	-40 to + 85	°C
Max Storage Temperature	-65 to +150	°C
ESD Rating - Human Body Model (HBM)	Class 1B	
Moisture Sensitivity Level (MSL)	MSL 1	

Operation of this device beyond any one of these limits may cause permanent damage. For reliable continuous operation, the device voltage and current must not exceed the maximum operating values specified in the table on page one. Bias Conditions should also satisfy the following expression: $I_DV_D \! < \! (T_J \! - \! T_L) / R_{TH}, j \! - \! l \text{ and } T_L \! = \! T_{LEAD}$



Caution! ESD sensitive device.

Exceeding any one or a combination of the Absolute Maximum Rating conditions may cause permanent damage to the device. Extended application of Absolute Maximum Rating conditions to the device may reduce device reliability. Specified typical performance or functional operation of the device under Absolute Maximum Rating conditions is not implied.

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RFMD Green: RoHS compliant per EU Directive 2002/95/EC, halogen free per IEC 61249-2-21, < 1000 ppm each of antimony trioxide in polymeric materials and red phosphorus as a flame retardant, and <2% antimony in solder.

Typical RF Performance - Broadband Application Circuit with $V_D = 5V$, $I_D = 90 \text{ mA}$

Parameter	Unit	0.1	0.4	0.9	1.5	1.9	2.2	2.5	3.5	3.8
		GHz*	GHz							
Small Signal Gain	dB	27.0	24.0	19.0	15.0	13.0	12.0	11.0	6.0	7.0
Noise Figure	dB	0.42	0.47	0.59	0.70	0.64	0.73	0.86	1.35	1.27
Output IP3	dBm	33.0	36.0	38.0	39.5	40.5	41.0	41.5	40.5	41.5
Output P1dB	dBm	22.3	22.7	23.0	23.2	23.4	23.7	23.9	22.2	22.9
Input Return Loss	dB	-9.5	-10.0	-14.5	-20.0	-21.0	-22.0	-22.5	-15.0	-11.5
Output Return Loss	dB	-29.0	-19.5	-17.0	-14.0	-13.0	-12.5	-12.5	-7.5	-15.5
Reverse Isolation	dB	-32.0	-29.0	-24.0	-20.0	-18.5	-17.5	-16.5	-15.5	-13.5

Test Conditions: $V_D = 5V$, $I_{DQ} = 90$ mA, OIP_3 Tone Spacing = 1 MHz, P_{OUT} per tone = 0 dBm, $T_L = 25$ °C, $Z_S = Z_L = 50\Omega$, *Bias Tee Data @ 100 MHz

Typical RF Performance - Broadband Application Circuit with V_D=3V, I_D=58mA

Parameter	Unit	0.1	0.4	0.9	1.5	1.9	2.2	2.5	3.5	3.8
		GHz*	GHz							
Small Signal Gain	dB	26.0	23.0	18.5	14.5	12.5	11.5	10.5	6.0	6.5
Noise Figure	dB	0.35	0.44	0.58	0.65	0.61	0.69	0.79	1.25	1.19
Output IP3	dBm	31.5	33.0	34.5	36.0	36.5	37.0	37.5	37.0	37.5
Output P1dB	dBm	18.8	18.9	19.1	19.4	19.9	20.2	20.1	18.9	19.2
Input Return Loss	dB	-8.0	-9.0	-13.0	-16.5	-18.5	-19.0	-19.0	-13.5	-10.0
Output Return Loss	dB	-26.0	-28.5	-23.5	-18.0	-16.5	-16.0	-15.5	-9.0	-14.0
Reverse Isolation	dB	-31.0	-28.0	-23.0	-19.0	-17.5	-16.0	-15.0	-14.5	-12.5

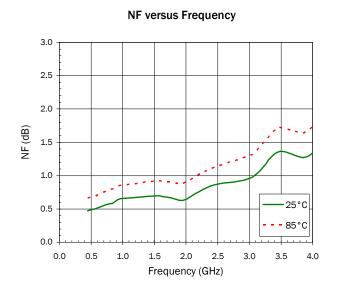
Test Conditions: V_D =3V, I_{DQ} =58mA, OIP_3 Tone Spacing=1MHz, P_{OUT} per tone=0dBm, T_L =25°C, Z_S = Z_L =50 Ω , *Bias Tee Data @ 100MHz

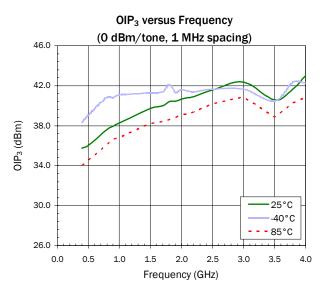
^{1.} Input RL can be improved in the 800 MHz to 1000 MHz band by adding a series inductor between the DC block and device input.

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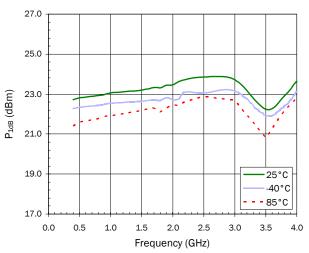


Typical RF Performance - Broadband Application Circuit with $V_D = 5V$, $I_D = 90 \text{ mA}$

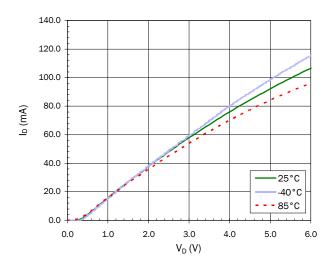




P_{1dB} versus Frequency

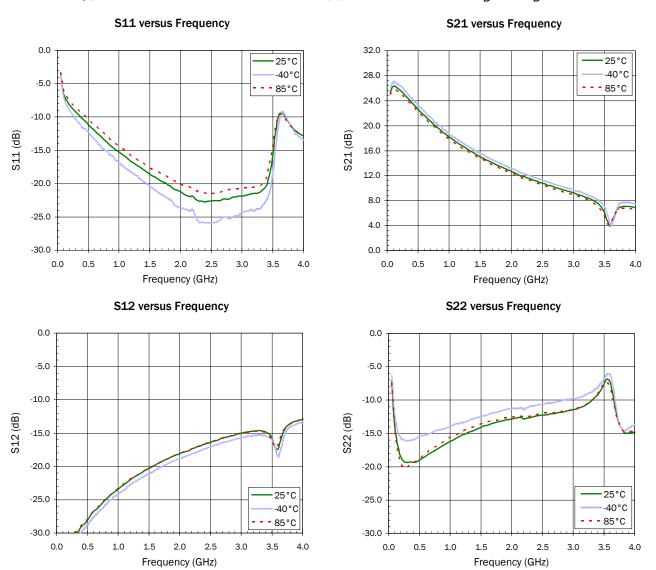


Device Current versus Voltage





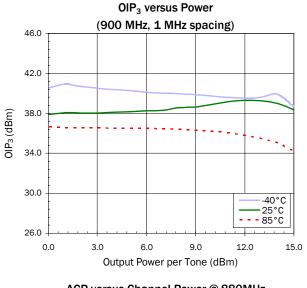
Typical RF Performance - Broadband Application Circuit with $V_D = 5V$, $I_D = 90 \text{ mA}$

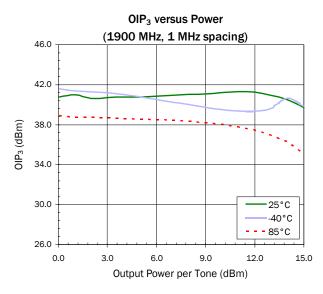




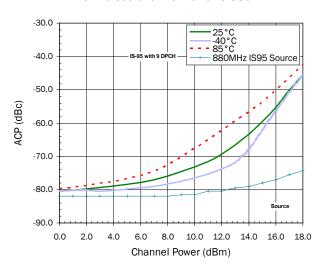


Typical RF Performance - Broadband Application Circuit with $V_D = 5V$, $I_D = 90 \text{ mA}$

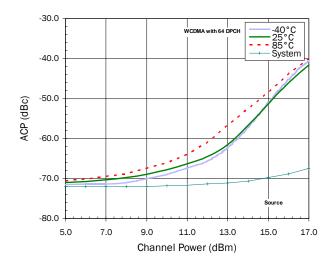




ACP versus Channel Power @ 880MHz

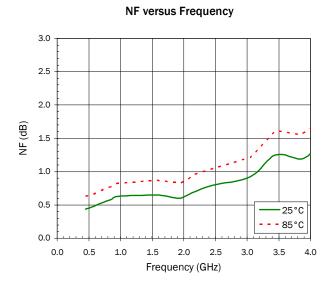


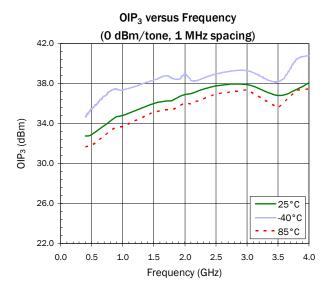
ACP versus Channel Power @ 2140MHz



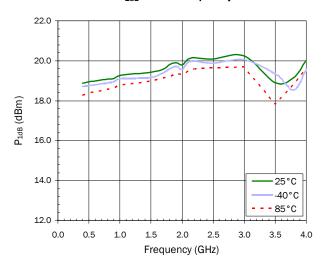


Typical RF Performance - Broadband Application Circuit with $V_D=3V$, $I_D=58mA$



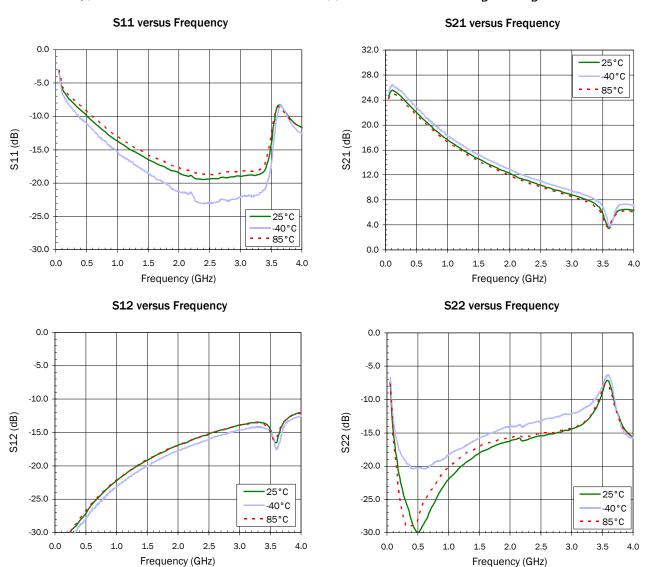


P_{1dB} versus Frequency



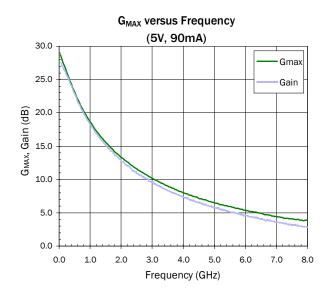


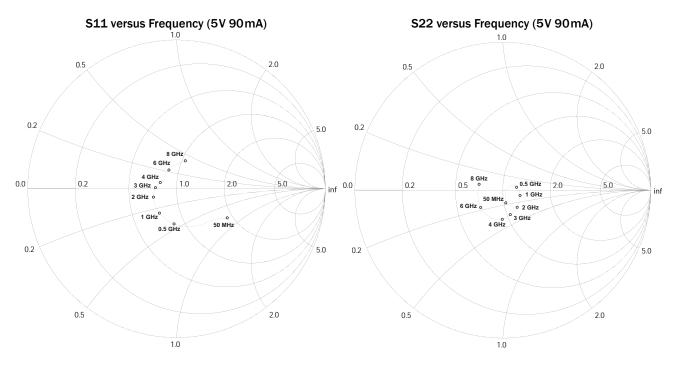
Typical RF Performance - Broadband Application Circuit with $V_D = 3V$, $I_D = 58 \text{ mA}$





De-embedded Device S-parameters (Bias Tee Data)

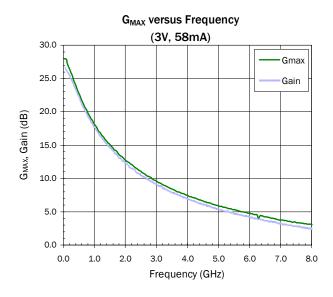


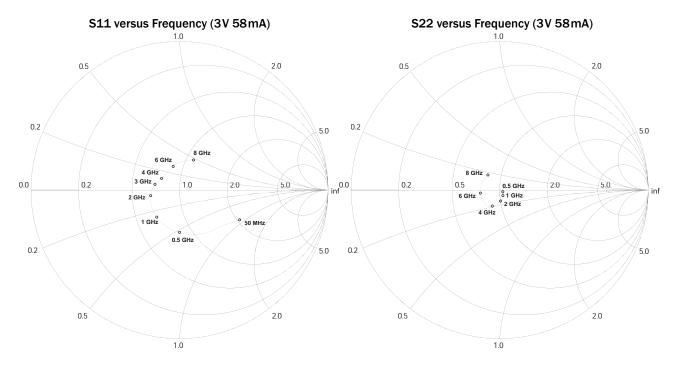






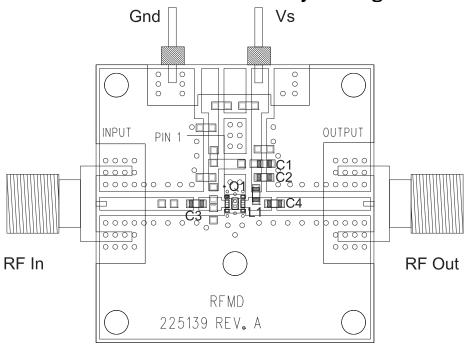
De-embedded Device S-Parameters (Bias Tee Data)







Evaluation Board Assembly Drawing



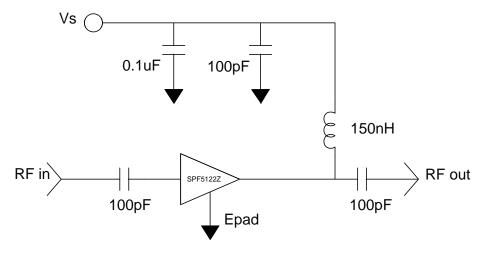
Evaluation Board Bill of Materials (BOM)

(400 MHz to 3000 MHz)

C1	AJB104KLRH, Rohm, 0.1uF
C2	MCH185A101JK, Rohm, 100pF
C3	MCH185A101JK, Rohm, 100pF
C4	MCH185A101JK, Rohm, 100pF
L1	LL1608-FSR15J, Toko, 150nH

Application Schematic

(400 MHz to 3000 MHz)

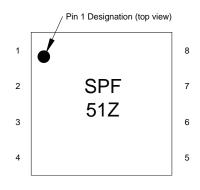




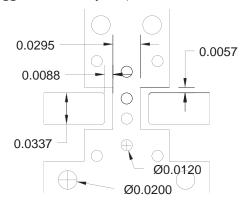
Pin Names and Description

Pin	Function	Description
1	N/A	Ground or No-Connect. No Connection Internal
2	RF IN	RF Input, DC Coupled and Matched to 50Ω. An External DC Block is Required.
3	N/A	Ground or No-Connect. No Connection Internal
4	N/A	Ground or No-Connect. No Connection Internal
5	N/A	Ground or No-Connect. No Connection Internal
6	N/A	Ground or No-Connect. No Connection Internal
7	RF OUT/BIAS	RF Output, Bias Applied Through This Pin. Matched to 50Ω .
8	N/A	Ground or No-Connect. No Connection Internal
EPAD	GND	EPAD Must be Conductively Attached to RF and DC Ground.

Part Identification

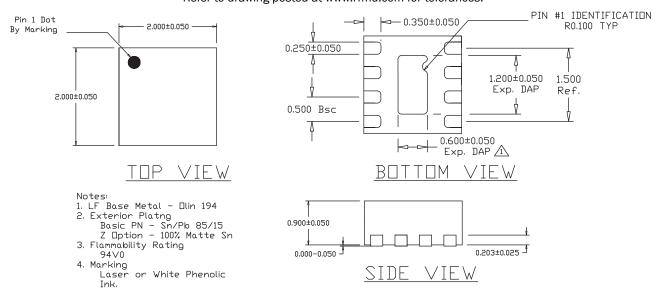


Suggested Pad Layout (Dimensions in inches)



Package Drawing

Dimensions in millimeters
Refer to drawing posted at www.rfmd.com for tolerances.





Ordering Information

Part Number	Description			
SPF5122Z	7" Reel with 3000 pieces			
SPF5122ZSQ	Sample Bag with 25 pieces			
SPF5122ZSR	7" Reel with 100 pieces			
SPF5122ZPCK1	400MHz to 3000MHz PCBA with 5-piece Sample Bag			